

<b>Notice of References Cited</b>	Application/Control No. 10/075,656	Applicant(s)/Patent Under Reexamination RICHTER, DETLEV	
	Examiner John J. Tabone, Jr.	Art Unit 2133	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0101376 A1	05-2003	Sanghani, Amit Dinesh	714/30
	B	US-2003/0120989 A1	06-2003	Zumkehr, John F.	714/738
	C	US-6,704,897 B1	03-2004	Takagi, Ryoichi	714/739
	D	US-5,751,151 A	05-1998	Levy et al.	324/537
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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